

Data Sheet April 12, 2007 FN3690.10

64ns Sample and Hold Amplifier

The HA5351 is a fast acquisition, wide bandwidth sample and hold amplifier, built with the Intersil HBC-10 BiCMOS process. This sample and hold amplifier offers a combination of desirable features; fast acquisition time (70ns to 0.01% maximum), excellent DC precision and extremely low power dissipation, making it ideal for use in systems that sample multiple signals and require low power.

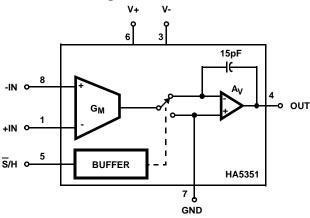
The HA5351 is in an open loop configuration with fully differential inputs providing flexibility for user defined feedback. In unity gain the HA5351 is completely self-contained and requires no external components. The on-chip 15pF hold capacitor is completely isolated to minimizing droop rate and reducing sensitivity to pedestal error. The HA5351 is available in 8 lead SOIC package for minimizing board space and ease of layout.

Ordering Information

| PART NUMBER | PART MARKING | TEMP. RANGE (°C) | PACKAGE | PKG. DWG. # |
|---------------------|-----------------|---------------------|------------------------|----------------|
| HA5351IB | 5351 I | -40 to +85 | 8 Ld SOIC | M8.15 |
| HA5351IBZ (Note) | 5351 IBZ | -40 to +85 | 8 Ld SOIC (Pb-free) | M8.15 |

NOTE: Intersil Pb-free plus anneal products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

Functional Diagram



Features

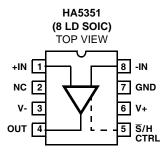
| • Fast Acquisition to 0.01%70ns (Max) |
|---|
| Low Offset Error |
| Low Pedestal Error |
| Low Droop Rate 2μV/μs (Max) |
| Wide Unity Gain Bandwidth 40MHz |
| Low Power Dissipation |
| Total Harmonic Distortion (Hold Mode)72dBc (V_{IN} = 5V_{P-P} at 1MHz) |

- · Fully Differential Inputs
- · On Chip Hold Capacitor
- Pb-Free Plus Anneal Available (RoHS Compliant)

Applications

- Synchronous Sampling
- Wide Bandwidth A/D Conversion
- Deglitching
- Peak Detection
- High Speed DC Restore

Pinout



Absolute Maximum Ratings

Voltage Between V+ and V- Terminals ... +11V Differential Input Voltage ... 6V Voltage Between Sample and Hold Control and Ground ... +5.5V Output Current, Continuous ... ±37mA

Operating Conditions

Thermal Information

| Thermal Resistance (Typical, Note 1) | θ _{JA} (°C/W) |
|--|------------------------|
| SOIC Package | 160 |
| Maximum Junction Temperature (Plastic Package) | +150°C |
| Maximum Storage Temperature Range65 | °C to +150°C |
| Pb-free reflow profile | see link below |
| http://www.intersil.com/pbfree/Pb-FreeReflow.asp | |

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. $\theta_{\mbox{\scriptsize JA}}$ is measured with the component mounted on an evaluation PC board in free air.

Electrical Specifications

Test Conditions: $V_{SUPPLY} = \pm 5V$; $C_H = Internal = 15pF$, Digital Input: $V_{IL} = 0V$ (Sample), $V_{IH} = 4.0V$ (Hold). Non-Inverting Unity Gain Configuration (Output Tied to -Input), $C_L = 5pF$, Unless Otherwise Specified

| PARAMETER | TEST CONDITIONS | TEMP. (°C) | MIN | TYP | MAX | UNITS |
|--|----------------------------------|---------------|------|------|------|-------------------|
| INPUT CHARACTERISTICS | <u> </u> | ' | 1 | " | " | <u>'</u> |
| Input Voltage Range | | Full | -2.5 | - | +2.5 | V |
| Input Resistance (Note 2) | | 25 | 100 | 500 | - | kΩ |
| Input Capacitance | | 25 | - | - | 5 | pF |
| Input Offset Voltage | | 25 | -2 | - | 2 | mV |
| Offset Voltage Temperature Coefficient | | Full | -3.0 | 15 | 3.0 | mV μV/°C |
| Bias Current | | Full | _ | 2.5 | 5 | μΑ |
| Offset Current | | Full | -1.5 | 2.5 | +1.5 | μΑ |
| Common Mode Range | | Full | -2.5 | _ | +2.5 | V |
| Common Mode Rejection Ratio | ±2.5V, Note 3 | Full | 60 | 80 | - | dB |
| TRANSFER CHARACTERISTICS | ±2.5 V, 140to 0 | ı un | - 00 | 00 | | ub |
| Large Signal Voltage Gain | V _{OUT} = ±2.5V | 25 | 95 | 108 | - | dB |
| | 001 | Full | 85 | - | - | dB |
| Unity Gain -3dB Bandwidth | | 25 | - | 40 | - | MHz |
| TRANSIENT RESPONSE | | " | | | | |
| Rise Time | 200mV Step | 25 | - | 8.5 | - | ns |
| Overshoot | 200mV Step | 25 | 0 | - | 30 | % |
| Slew Rate | 5V Step | Full | 88 | 105 | - | V/µs |
| DIGITAL INPUT CHARACTERISTICS | | | 1 | | | |
| Input Voltage | V _{IH} | 25, 85 | 2.1 | - | 5.0 | V |
| | | -40 | 2.4 | - | 5.0 | V |
| | V _{IL} | Full | 0 | - | 0.8 | V |
| Input Current | $V_{IL} = 0V$ | Full | -1.0 | - | 1.0 | μΑ |
| | V _{IH} = 5V | Full | -1.0 | - | 1.0 | μΑ |
| OUTPUT CHARACTERISTICS | | | | | | |
| Output Voltage | $R_L = 510\Omega$ | Full | -3.0 | - | +3.0 | V |
| Output Current | $R_L = 100\Omega$ | 25, 85 | 20 | 25 | - | mA |
| | | -40 | 15 | - | - | mA |
| Full Power Bandwidth | $5V_{P-P}$, $A_V = +1$, $-3dB$ | Full | - | 13 | - | MHz |
| Output Resistance | Hold Mode | 25 | - | 0.02 | - | Ω |
| Total Output Noise | Sample Mode | 25 | - | 325 | - | μV _{RMS} |
| (DC to 10MHz) | Hold Mode | 25 | - | 325 | - | μV _{RMS} |

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| PARAMETER | TEST CONDITIONS | TEMP. (°C) | MIN | TYP | MAX | UNITS |
|---|--|---------------|-----|-------|-----|-------|
| DISTORTION CHARACTERISTICS | · | | | | | • |
| SAMPLE MODE | | | | | | |
| Total Harmonic Distortion | $V_{IN} = 4.5 V_{P-P}, f_{IN} = 100 kHz$ | 25 | - | -80 | - | dBc |
| | $V_{IN} = 5V_{P-P}$, $f_{IN} = 1MHz$ | 25 | - | -74 | - | dBc |
| | $V_{IN} = 1V_{P-P}$, $f_{IN} = 10MHz$ | 25 | - | -80 - | dBc | |
| Signal to Noise Ratio (RMS Signal to RMS Noise) | $V_{IN} = 4.5V_{P-P}, f_{IN} = 100kHz$ | 25 | - | 73 | - | dB |
| HOLD MODE (50% Duty Cycle S/H) | | • | • | | | |
| Total Harmonic Distortion | $V_{IN} = 4.5V_{P-P}$, $f_{IN} = 100kHz$, $f_{S} \cong 100kHz$ | 25 | - | -78 | - | dBc |
| | $V_{IN} = 5V_{P-P}, f_{IN} = 1MHz,$ $f_S \cong 1MHz$ | 25 | - | -72 | - | dBc |
| | $V_{IN} = 1V_{P-P}$, $f_{IN} = 10MHz$, $f_{S} \cong 1MHz$ | 25 | - | -51 | - | dBc |
| Signal to Noise Ratio (RMS Signal to RMS Noise) | $V_{IN} = 4.5V_{P-P}$, $f_{IN} = 100kHz$, $f_{S} \cong 100kHz$ | 25 | - | 70 | - | dB |
| SAMPLE AND HOLD CHARACTERISTIC | cs | • | • | | | |
| Acquisition Time | 0V to 2.0V Step to ±1mV | 25 | - | 53 | - | ns |
| | 0V to 2.0V Step to 0.01% (±200μV) | 25 | - | 64 | 70 | ns |
| | -2.5V to +2.5V Step to 0.01% $(\pm 500 \mu V)$ | 25 | - | 90 | 100 | ns |
| Droop Rate | | 25 | - | 0.3 | - | μV/μs |
| | | Full | -2 | - | 2 | μV/μs |
| Hold Step Error | $V_{IL} = 0V, V_{IH} = 4.0V, t_R = 5ns$ | Full | -10 | - | +10 | mV |
| Hold Mode Settling Time | To ±1mV | 25 | - | 50 | - | ns |
| Hold Mode Feedthrough | 5V _{P-P} , 500kHz, Sine | 25 | - | 72 | - | dB |
| EADT (Effective Aperture Delay Time) | | 25 | - | +1 | - | ns |
| Aperture Time (Note 2) | | 25 | - | 10 | - | ns |
| Aperture Uncertainty | | 25 | - | 10 | 20 | ps |
| POWER SUPPLY CHARACTERISTICS | | | | | | |
| Positive Supply Current | | Full | - | 20 | 22 | mA |
| Negative Supply Current | | Full | - | 20 | 22 | mA |
| PSRR | 10% Delta | Full | 60 | 74 | - | dB |

NOTES:

- 2. Derived from Computer Simulation only, not tested.
- 3. +CMRR is measured from 0V to +2.5V, -CMRR is measured from 0V to -2.5V.

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Typical Performance Curves

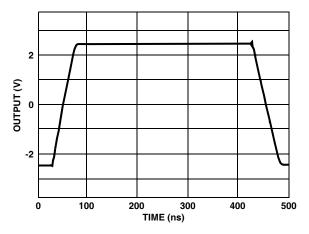


FIGURE 1. LARGE SIGNAL RESPONSE

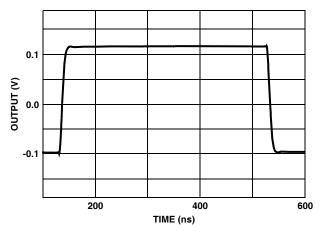


FIGURE 2. SMALL SIGNAL RESPONSE

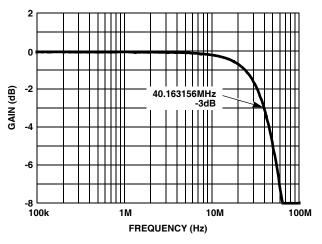


FIGURE 3. UNITY GAIN FREQUENCY RESPONSE

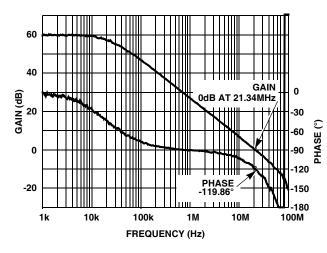


FIGURE 4. CLOSED LOOP GAIN/PHASE A_V = +1000

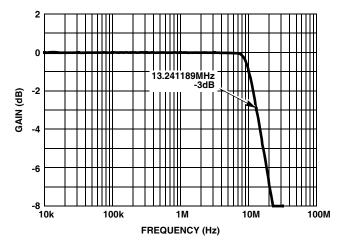


FIGURE 5. 5V_{P-P} FULL POWER FREQUENCY RESPONSE

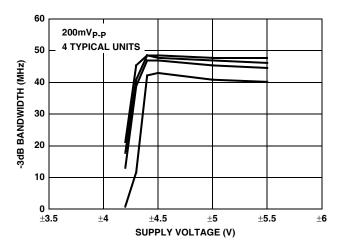


FIGURE 6. -3dB BANDWIDTH vs SUPPLY VOLTAGE

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Typical Performance Curves (Continued)

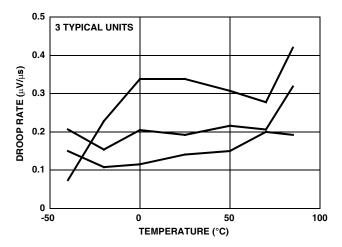
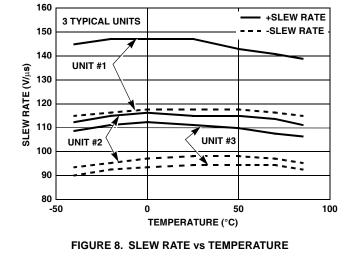


FIGURE 7. DROOP RATE vs TEMPERATURE



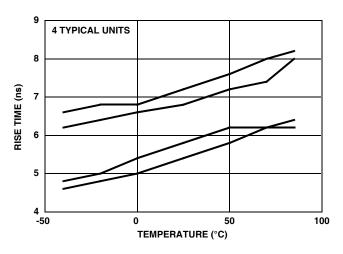


FIGURE 9. RISE TIME vs TEMPERATURE

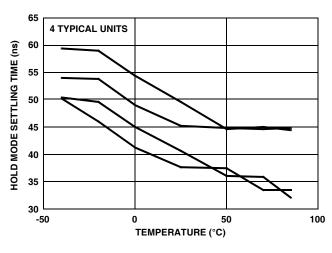


FIGURE 10. HOLD MODE SETTLING vs TEMPERATURE

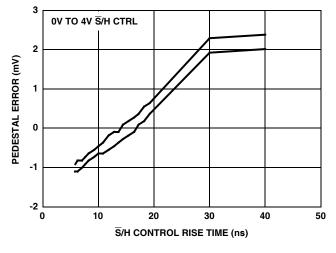


FIGURE 11. PEDESTAL vs S/H CONTROL RISE TIME

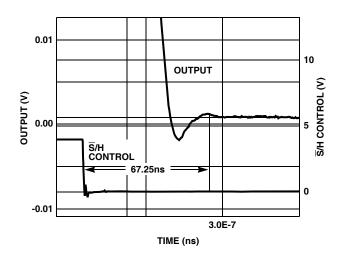


FIGURE 12. ACQUISITION TIME (0.01%, 0V TO 2V STEP)

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Typical Performance Curves (Continued)

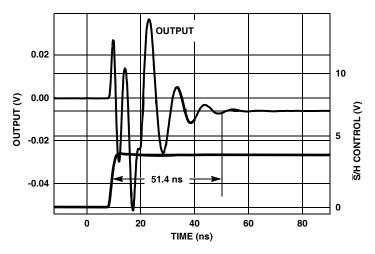


FIGURE 13. HOLD MODE SETTLING TIME ($\pm 200 \mu V$)

Die Characteristics

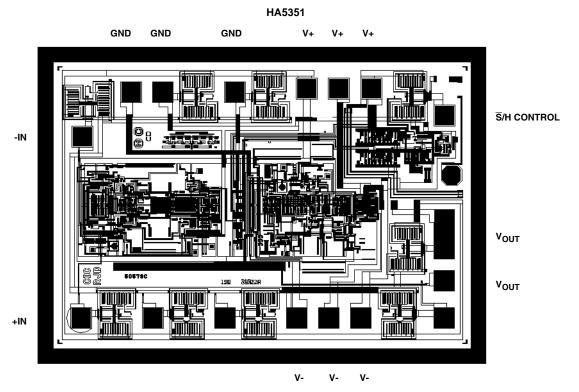
SUBSTRATE POTENTIAL:

V-

TRANSISTOR COUNT:

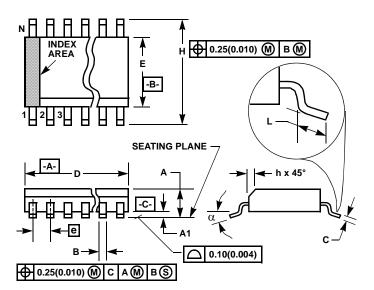
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Metallization Mask Layout



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Small Outline Plastic Packages (SOIC)



NOTES:

- Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
- 2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
- Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
- Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side
- 5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
- 6. "L" is the length of terminal for soldering to a substrate.
- 7. "N" is the number of terminal positions.
- 8. Terminal numbers are shown for reference only.
- The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
- Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

M8.15 (JEDEC MS-012-AA ISSUE C)
8 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE

| | INCHES | | MILLIN | MILLIMETERS | | |
|--------|--------|-----------|--------|-------------|-------|--|
| SYMBOL | MIN | MAX | MIN | MAX | NOTES | |
| Α | 0.0532 | 0.0688 | 1.35 | 1.75 | - | |
| A1 | 0.0040 | 0.0098 | 0.10 | 0.25 | - | |
| В | 0.013 | 0.020 | 0.33 | 0.51 | 9 | |
| С | 0.0075 | 0.0098 | 0.19 | 0.25 | - | |
| D | 0.1890 | 0.1968 | 4.80 | 5.00 | 3 | |
| Е | 0.1497 | 0.1574 | 3.80 | 4.00 | 4 | |
| е | 0.050 | 0.050 BSC | | 1.27 BSC | | |
| Н | 0.2284 | 0.2440 | 5.80 | 6.20 | - | |
| h | 0.0099 | 0.0196 | 0.25 | 0.50 | 5 | |
| L | 0.016 | 0.050 | 0.40 | 1.27 | 6 | |
| N | 3 | 3 | 8 | | 7 | |
| α | 0° | 8° | 0° | 8° | - | |

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